



dsPIC33FJ32MC302/304, dsPIC33FJ64MCX02/X04 and dsPIC33FJ128MCX02/X04

dsPIC33FJ32MC302/304, dsPIC33FJ64MCX02/X04 and dsPIC33FJ128MCX02/X04 Family Silicon Errata and Data Sheet Clarification

The dsPIC33FJ32MC302/304, dsPIC33FJ64MCX02/X04 and dsPIC33FJ128MCX02/X04 family devices that you have received conform functionally to the current Device Data Sheet (DS70291G), except for the anomalies described in this document.

The silicon issues discussed in the following pages are for silicon revisions with the Device and Revision IDs listed in [Table 1](#). The silicon issues are summarized in [Table 2](#).

The errata described in this document will be addressed in future revisions of the dsPIC33FJ32MC302/304, dsPIC33FJ64MCX02/X04 and dsPIC33FJ128MCX02/X04 silicon.

Note: This document summarizes all silicon errata issues from all revisions of silicon, previous as well as current. Only the issues indicated in the last column of [Table 2](#) apply to the current silicon revision (A5).

Data Sheet clarifications and corrections start on [Page 13](#), following the discussion of silicon issues.

The silicon revision level can be identified using the current version of MPLAB® IDE and Microchip's programmers, debuggers and emulation tools, which are available at the Microchip corporate web site (www.microchip.com).

For example, to identify the silicon revision level using MPLAB IDE in conjunction with MPLAB ICD 3 or PICKIT™ 3:

1. Using the appropriate interface, connect the device to the MPLAB ICD 3 programmer/debugger or PICKIT 3.
2. From the main menu in MPLAB IDE, select Configure>Select Device, and then select the target part number in the dialog box.
3. Select the MPLAB hardware tool (Debugger>Select Tool).
4. Perform a "Connect" operation to the device (Debugger>Connect). Depending on the development tool used, the part number *and* Device Revision ID value appear in the **Output** window.

Note: If you are unable to extract the silicon revision level, please contact your local Microchip sales office for assistance.

The Device and Revision ID values for the various dsPIC33FJ32MC302/304, dsPIC33FJ64MCX02/X04 and dsPIC33FJ128MCX02/X04 silicon revisions are shown in [Table 1](#).

TABLE 1: SILICON DEVREV VALUES

Part Number	Device ID ⁽¹⁾	Revision ID for Silicon Revision ⁽²⁾				
		A1	A2	A3	A4	A5
dsPIC33FJ32MC302	0x0601	0x3001	0x3002	0x3002	0x3003	0x3004
dsPIC33FJ32MC304	0x0603					
dsPIC33FJ64MC202	0x0611					
dsPIC33FJ64MC204	0x0613					
dsPIC33FJ64MC802	0x0619					
dsPIC33FJ64MC804	0x061B					
dsPIC33FJ128MC202	0x0621	0x3001	0x3002	0x3002	0x3003	0x3004
dsPIC33FJ128MC204	0x0623					
dsPIC33FJ128MC802	0x0629					
dsPIC33FJ128MC804	0x062B					

Note 1: The Device and Revision IDs (DEVID and DEVREV) are located at the last two implemented addresses in program memory.

2: Refer to the “dsPIC33F/PIC24H Flash Programming Specification” (DS70152) for detailed information on Device and Revision IDs for your specific device.

TABLE 2: SILICON ISSUE SUMMARY

Module	Feature	Item Number	Issue Summary	Affected Revisions ⁽¹⁾				
				A1	A2	A3	A4	A5
UART	IR Mode	1.	The 16x baud clock signal on the BCLK pin is present only when the module is transmitting.	X	X	X	X	X
UART	High-Speed Mode	2.	When the UART is in 4x mode (BRGH = 1) and using two Stop bits (STSEL = 1), it may sample the first Stop bit instead of the second one.	X	X	X	X	X
SPI	Transmit Operation	3.	The SPIx Transmit Buffer Full (SPITBF) flag does not get set immediately after writing to the buffer.	X	X	X	X	X
SPI	Frame Mode	4.	The SPIx module will generate incorrect frame synchronization pulses in Frame Master mode if FRMDLY = 1.	X	X	X	X	X
I ² C	SFR Writes	5.	The BCL bit in I2CxSTAT can only be cleared with word instructions, and can be corrupted with byte instructions and bit operations.	X	X	X	X	X
I ² C	10-Bit Addressing	6.	When the I ² C module is configured for 10-Bit Addressing, using the same Address bits (A10 and A9) as other I ² C devices, A10 and A9 bits may not work as expected.	X	X	X	X	X
I ² C	10-Bit Addressing	7.	When the I ² C module is configured as a 10-bit slave with an address of 0x02, the I2CxRCV register content for the lower address byte is 0x01 rather than 0x02.	X	X	X	X	X
I ² C	—	8.	With the I ² C module enabled, the PORT bits and external interrupt input functions (if any) associated with the SCLx and SDAx pins will not reflect the actual digital logic levels on the pins.	X	X	X	X	X
I ² C	10-Bit Addressing	9.	The 10-bit slave does not set the RBF flag or load the I2CxRCV register on address match if the Least Significant bits (LSbs) of the address are the same as the 7-bit reserved addresses.	X	X	X	X	X
I ² C	—	10.	After the ACKSTAT bit is set when receiving a NACK, it may be cleared by the reception of a Start or Stop bit.	X	X	X	X	X
UART	Interrupts	11.	The UART error interrupt may not occur, or may occur at an incorrect time, if multiple errors occur during a short period of time.	X	X	X	X	X
UART	IR Mode	12.	When the UART module is operating in 8-bit mode (PDSEL<1:0> = 0x) and using the IrDA [®] encoder/decoder (IREN = 1), the module incorrectly transmits a data payload of 80h as 00h.	X	X	X	X	X
Comparator	Output Pin	13.	When the CxOUTEN (CMCON) bit is set, the comparator output pin cannot be used as a general purpose I/O pin, even if the comparator is disabled.	X	X	X	X	X
Internal Voltage Regulator	Sleep Mode	14.	When the VREGS bit (RCON<8>) is set to a logic '0', the device may reset and higher Sleep current may be observed.	X	X	X	X	X
PSV Operations	—	15.	An address error trap occurs in certain addressing modes when accessing the first four bytes of any PSV page.	X	X	X	X	X
ECAN [™]	Sleep Mode	16.	The WAKIF bit in the CiINTF register cannot be cleared by software instruction after the device is interrupted from Sleep due to activity on the CAN bus.	X	X	X	X	X

Note 1: Only those issues indicated in the last column apply to the current silicon revision.

TABLE 2: SILICON ISSUE SUMMARY (CONTINUED)

Module	Feature	Item Number	Issue Summary	Affected Revisions ⁽¹⁾				
				A1	A2	A3	A4	A5
ECAN™	Receive Operation	17.	The ECAN™ module may not store the received data in the correct location.	X	X	X		
CPU	EXCH Instruction	18.	The EXCH instruction does not execute correctly.	X	X	X	X	X
PWM	Debug Mode	19.	PTMR does not keep counting down after halting code execution in Debug mode.	X	X	X	X	X
PWM	Doze Mode	20.	The Motor Control PWM module generates more interrupts than expected when Doze mode is used and the output postscale value is different than 1:1.	X	X	X	X	X
SPI	Transmit Operation	21.	Writing to the SPIxBUF register as soon as the TBF bit is cleared will cause the SPIx module to ignore written data.	X	X	X	X	X
UART	Break Character Generation	22.	The UARTx module will not generate back-to-back Break characters.	X	X	X	X	X
QE1	Timer Gated Accumulation Mode	23.	When Timer Gated Accumulation mode is enabled, the QE1 does not generate an interrupt on every falling edge.	X	X	X	X	X
QE1	Timer Gated Accumulation Mode	24.	When Timer Gated Accumulation mode is enabled, and an external signal is applied, the POSxCNT increments and generates an interrupt after a match with MAXxCNT.	X	X	X	X	X
Audio DAC	Voltage Specifications	25.	The audio DAC positive and negative output differential voltages may not meet the specifications listed in the data sheet.	X	X	X		
ADC	Current Consumption in Sleep Mode	26.	If the ADC module is in an enabled state when the device enters Sleep mode, the Power-Down (IPD) current of the device may exceed the device data sheet specifications.	X	X	X	X	X
JTAG	Boundary Scan	27.	On 28-pin devices, boundary scan does not function correctly for Pin 7.	X	X	X	X	X
RTCC	Operation During Reset	28.	The RTCC module gets reset on any device Reset, instead of getting reset only on a POR or BOR.	X	X	X	X	X
All	+150°C Operation	29.	These revisions of silicon only support +140°C operation instead of +150°C for high-temperature operating temperature.	X	X	X		
I/O Port	Data Direction Setting	30.	When the RB8 pin is in open-drain configuration, the data direction depends upon the TRISB9 bit instead of the TRISB8 bit.	X	X	X	X	X
CPU	Interrupt Disable	31.	When a previous DISI instruction is active (i.e., the DISICNT register is non-zero), and the value of the DISICNT register is updated manually, the DISICNT register freezes and disables interrupts permanently.	X	X	X	X	X
CPU	div.sd	32.	When using the div.sd instruction, the Overflow bit is not getting set when an overflow occurs.	X	X	X	X	X
UART	TX Interrupt	33.	A Transmit (TX) interrupt may occur before the data transmission is complete.	X	X	X	X	X
JTAG	Flash Programming	34.	JTAG Flash programming is not supported.	X	X	X	X	X
I ² C	Slave mode	35.	Clock stretching may not occur when enabled.	X	X	X	X	X

Note 1: Only those issues indicated in the last column apply to the current silicon revision.

Silicon Errata Issues

Note: This document summarizes all silicon errata issues from all revisions of silicon, previous as well as current. Only the issues indicated by the shaded column in the following tables apply to the current silicon revision (**A5**).

1. Module: UART

When the UARTx is configured for IR interface operations (UxMODE<9:8> = 11), the 16x baud clock signal on the BCLK pin is present only when the module is transmitting. The pin is Idle at all other times.

Work around

Configure one of the output compare modules to generate the required baud clock signal when the UARTx is receiving data or in an Idle state.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

2. Module: UART

When the UARTx is in 4x mode (BRGH = 1) and using two Stop bits (STSEL = 1), it may sample the first Stop bit instead of the second one.

This issue does not affect the other UARTx configurations.

Work around

Use the 16x baud rate option (BRGH = 0) and adjust the baud rate accordingly.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

3. Module: SPI

The SPIx Transmit Buffer Full (SPITBF) flag does not get set immediately after writing to the buffer.

Work around

After a write to the SPIx buffer, poll the SPITBF flag until the flag gets set, indicating that the transmit buffer is not full. Afterwards, poll the SPITBF flag again until the flag gets cleared, indicating that the transmit has started and that the transmit buffer is empty, and another write can occur.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

4. Module: SPI

The SPIx module will generate incorrect frame synchronization pulses when configured in Frame Master mode if the start of data is selected to coincide with the start of the frame synchronization pulse (FRMEN = 1, SPIFSD = 0, FRMDLY = 1). However, the module functions correctly in Frame Slave mode and also in Frame Master mode if FRMDLY = 0.

Work around

If DMA is not being used, manually drive the SSx pin (x = 1 or 2) high, using the associated PORT register, and then drive it low after the required 1 bit time pulse width. This operation needs to be performed when the transmit buffer is written.

If DMA is being used, and if no other peripheral modules are using DMA transfers, use a timer interrupt to periodically generate the frame synchronization pulse (using the method described above) after every 8 or 16-bit period (depending on the data word size configured using the MODE16 bit).

If FRMDLY = 0, no work around is needed.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

5. Module: I²C

The BCL bit in I2CxSTAT can only be cleared with word instructions, and can be corrupted with byte instructions and bit operations.

Work around

Use word instructions to clear the BCL bit.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

6. Module: I²C

If there are two I²C devices on the bus, one of them is acting as the master receiver and the other as the slave transmitter. If both devices are configured for 10-Bit Addressing mode, and have the same value in the A10 and A9 bits of their addresses, then when the slave select address is sent from the master, both the master and slave Acknowledge it. When the master sends out the read operation, both the master and the slave enter into Read mode and both of them transmit the data. The resultant data will be the ANDing of the two transmissions.

Work around

In all I²C devices, the addresses, as well as bits, A10 and A9, should be different.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

7. Module: I²C

When the I²C module is configured as a 10-bit slave with an address of 0x02, the I2CxRCV register content for the lower address byte is 0x01, rather than 0x02; however, the module Acknowledges both address bytes.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

8. Module: I²C

With the I²C module enabled, the PORT bits and external interrupt input functions (if any), associated with the SCLx and SDAx pins, do not reflect the actual digital logic levels on the pins.

Work around

If the SDAx and/or SCLx pins need to be polled, these pins should be connected to other port pins in order to be read correctly. This issue *does not* affect the operation of the I²C module.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

9. Module: I²C

In 10-Bit Addressing mode, some address matches do not set the RBF flag or load the I2CxRCV register, I2CxRCV, if the lower address byte matches the reserved addresses. In particular, these include all addresses with the form, 'xx0000xxxx' and 'xx1111xxxx', with the following exceptions:

- '001111000x'
- '011111001x'
- '101111010x'
- '111111011x'

Work around

Ensure that the lower address byte in 10-Bit Addressing mode does not match any 7-bit reserved addresses.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

10. Module: I²C

When the I²C module is operating in either Master or Slave mode, after the ACKSTAT bit is set when receiving a NACK, it may be cleared by the reception of a Start or Stop bit.

Work around

Store the value of the ACKSTAT bit immediately after receiving a NACK from the master.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

11. Module: UART

The UARTx error interrupt may not occur, or may occur at an incorrect time, if multiple errors occur during a short period of time.

Work around

Read the error flags in the UxSTA register whenever a byte is received to verify the error status. In most cases, these bits will be correct, even if the UARTx error interrupt fails to occur.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

12. Module: UART

When the UARTx is operating in 8-bit mode (PDSEL<1:0> = 0x) and using the IrDA encoder/decoder (IREN = 1), the module incorrectly transmits a data payload of 80h as 00h.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

13. Module: Comparator

If the CxOUTEN (CMCON) bit is set and the Comparator x Enable bit, CxEN (CMCON), is disabled, the remappable Comparator Output pins, C1OUT and C2OUT, cannot be used as general purpose I/O pins.

Work around

When the comparator module is disabled, the CxOUTEN bit should be reset so that the remappable Comparator Output pins, C1OUT and C2OUT, are not driven onto the output pad.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

14. Module: Internal Voltage Regulator

When the VREGS bit (RCON<8>) is set to a logic '0', the device may reset and a higher Sleep current may be observed.

Work around

Ensure that the VREGS bit (RCON<8>) is set to a logic '1' for device Sleep mode operation.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

15. Module: PSV Operations

An address error trap occurs in certain addressing modes when accessing the first four bytes of a PSV page. This only occurs when using the following addressing modes:

- MOV.D
- Register Indirect Addressing (Word or Byte mode) with Pre/Post-Decrement

Work around

Do not perform PSV accesses to any of the first four bytes using the above addressing modes. For applications using the C language, MPLAB® C30 Version 3.11 or higher provides the following command-line switch that implements a work around for the erratum.

`-merrata=psv_trap`

Refer to the readme.txt file in the MPLAB C30 v3.11 toolsuite for further details.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

16. Module: ECAN™

The WAKIF bit in the CiINTF register cannot be cleared by software instructions after the device is interrupted from Sleep due to activity on the CAN bus.

When the device wakes up from Sleep due to CAN bus activity, the ECAN module is placed in Operational mode. The ECAN event interrupt occurs due to the WAKIF flag. Trying to clear the flag in the Interrupt Service Routine (ISR) may not clear the flag. The WAKIF bit being set will not cause repetitive Interrupt Service Routine execution.

Work around

Although the WAKIF bit does not clear, the device Sleep and ECAN wake function continue to work as expected. If the ECAN event is enabled, the CPU will enter the Interrupt Service Routine due to the WAKIF flag getting set. The application can maintain a secondary flag, which tracks the device Sleep and wake events.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

17. Module: ECAN

The ECAN module may not store received data in the correct location. When this occurs, the receive buffers will become corrupted. In addition, it is also possible for the transmit buffers to become corrupted. This issue is more likely to occur as the CAN bus speed approaches 1 Mbps.

Work around

Do not use the DMA with ECAN in Peripheral Indirect mode. Use the DMA in Register Indirect mode, Continuous mode enabled and Ping-Pong mode disabled. The receive DMA channel count should be set to 8 words. The transmit DMA channel count should be set for the actual message size (maximum of 7 words for Extended CAN messages and 6 words for Standard CAN messages). To simplify application error handling while using this mode, only one TX buffer should be used. While message filtering is not affected, messages will not be stored at distinct RX buffers. Instead, all messages are stored contiguously in memory. The start of this memory is pointed to by the receive DMA channel. The application must still clear the RXFULx flags and other interrupt flags. The application must also manage the RX buffer memory.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X					

18. Module: CPU

The EXCH instruction does not execute correctly.

Work around

If writing source code in assembly, the recommended work around is to replace:

```
EXCH    Wsource, Wdestination
```

with:

```
PUSH    Wdestination
MOV     Wsource, Wdestination
POP     Wsource
```

If using the MPLAB C30 C compiler, specify the compiler option: -merrata=exch (*Project > Build Options > Projects > MPLAB C30 > Use Alternate Settings*).

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

19. Module: PWM

If the PTDIR bit is set (when PTMR is counting down), and the CPU execution is halted (after a breakpoint is reached), PwTMR will start counting up as if PTDIR was zero.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

20. Module: PWM

When the device is operated in Doze mode and the Motor Control PWM module has a postscaler set to any value different than 1:1 (PTOPS<3:0> > 0 in the PxTCON register), the Motor Control PWM module generates more interrupts than expected.

Work around

Do not use Doze mode with the Motor Control PWM if the time base output postscaler is different than 1:1 (PTOPS<3:0> > 0 in the PxTCON register).

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

21. Module: SPI

Writing to the SPIxBUF register as soon as the TBF bit is cleared will cause the SPIx module to ignore the written data. Applications which use SPIx with DMA will not be affected by this erratum.

Work around

After the TBF bit is cleared, wait for a minimum duration of one SPI clock before writing to the SPIxBUF register.

Alternatively, do one of the following:

- Poll the RBF bit and wait for it to get set before writing to the SPIxBUF register
- Poll the SPIx interrupt flag and wait for it to get set before writing to the SPIxBUF register
- Use an SPI Interrupt Service Routine
- Use DMA

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

22. Module: UART

The UARTx module will not generate consecutive Break characters. Trying to perform a back-to-back Break character transmission will cause the UARTx module to transmit the dummy character, used to generate the first Break character, instead of transmitting the second Break character. Break characters are generated correctly if they are followed by a non-Break character transmission.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

23. Module: QEI

When the TQCS and TQGATE bits in the QEIXCON register are set, a QEI interrupt should be generated after an input pulse on the QEA input. This interrupt is not generated in the affected silicon.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

24. Module: QEI

When the TQCS and TQGATE bits in the QEIXCON register are set, the POSxCNT counter should not increment, but erroneously does, and if allowed to increment to match MAXxCNT, a QEI interrupt will be generated.

Work around

To prevent the erroneous increment of POSxCNT while running the QEI in Timer Gated Accumulation mode, initialize MAXxCNT = 0.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

25. Module: Audio DAC

The audio DAC positive differential output voltage and negative differential output voltage (Parameters DA01 and DA02, respectively) may not meet the specifications listed in the data sheet.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X					

26. Module: ADC

If the ADC module is in an enabled state when the device enters Sleep mode, as a result of executing a PWRSAV #0 instruction, the device Power-Down (IPD) current may exceed the specifications listed in the device data sheet. This may happen even if the ADC module is disabled by clearing the ADON bit prior to entering Sleep mode.

Work around 1:

In order to remain within the IPD specifications listed in the device data sheet, the user software must completely disable the ADC module by setting the ADC module disable bit in the corresponding Peripheral Module Disable x register (PMDx), prior to executing a PWRSAV #0 instruction.

Note: The ADC module must be reinitialized by the user application before resuming ADC operation.

Work around 2:

If the ADC module was previously initialized and enabled before entering Sleep, execute the lines of code provided in [Example 1](#).

Note: Unlike **Work around 1**, the user application does not need to reinitialize the ADC module; however, it is necessary to re-enable the ADC module by setting the ADON bit after waking from Sleep.

EXAMPLE 1:

```
AD1CON1bits.ADON = 0;           //Disable the ADC module
__asm__ volatile ("REPEAT #50"); //Wait 50 Tcy
__asm__ volatile ("NOP");        //Repeat NOP 51 times
Sleep();                        // Execute PWRSAV #0 and go to Sleep
```

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

27. Module: JTAG

On 28-pin devices, JTAG boundary scan does not function correctly for Pin 7. Both Pins 6 and 7 respond to stimulus applied to Pin 7.

Work around

Do not include Pin 7 in the JTAG boundary scan chain for 28-pin devices.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

28. Module: RTCC

The RTCC module gets reset on any device Reset, instead of getting reset only on a POR or BOR.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

29. Module: All

The affected silicon revisions listed below are not warranted for operation at +150°C.

Work around

Only use the affected revisions of silicon for the high-temperature operating range from -40°C to +140°C.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X					

30. Module: I/O Port

When the ODCB8 bit (Open-Drain Configuration) is set to '1', the data direction on the RB8 pin is controlled by the TRISB9 bit instead of the TRISB8 bit.

Work around

Do not use the RB8 pin in open-drain configuration while simultaneously using the RB9 pin.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

31. Module: CPU

When a previous DISI instruction is active (i.e., the DISCNT register is non-zero), and the value of the DISCNT register is updated manually, the DISCNT register freezes and disables interrupts permanently.

Work around

Avoid updating the DISCNT register manually. Instead, use the DISI #n instruction with the required value for 'n'.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

32. Module: CPU

When using the Signed 32-Bit by 16-Bit Division instruction, `div.sd`, the Overflow bit does not always get set when an overflow occurs.

Work around

Test for and handle overflow conditions outside of the `div.sd` instruction.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

33. Module: UART

When using UTXISEL<1:0> = 01 (interrupt when last character is shifted out of the Transmit Shift Register) and the final character is being shifted out through the Transmit Shift Register, the Transmit (TX) interrupt may occur before the final bit is shifted out.

Work around

If it is critical that the interrupt processing occur only when all transmit operations are complete, hold off the interrupt routine processing by adding a loop at the beginning of the routine that polls the Transmit Shift Register Empty bit (TRMT) before processing the rest of the interrupt.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

34. Module: JTAG

JTAG Flash programming is not supported.

Work around

None.

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

35. Module: I²C

In Slave mode, clock stretching may not occur during address detect, even when it has been enabled (STREN = 1). As a result, the SCLREL bit may not be cleared upon address reception when the R/W bit is '0'. This is seen in both 7-Bit and 10-Bit Addressing modes.

Work around

User software should read the Acknowledged address from the receive buffer before the data byte is received. User software also needs to configure the slave interrupt priority, such that, the interrupt latency time should be less (before the reception of the data byte).

Affected Silicon Revisions

A1	A2	A3	A4	A5			
X	X	X	X	X			

Data Sheet Clarifications

The following typographic corrections and clarifications are to be noted for the latest version of the device data sheet (DS70291G):

Note: Corrections are shown in **bold**. Where possible, the original bold text formatting has been removed for clarity.

1. Module: Electrical Characteristics

For Parameter DC60d (Base I_{PD}) in Table 31-7, the maximum value is corrected to read as 85 μ A.

2. Module: Electrical Characteristics

For Parameter DI51d (Input Leakage Current) in Table 31-9, the maximum value is corrected to read as ± 12 μ A.

3. Module: Electrical Characteristics

For Parameter F21 (Internal RC Accuracy) in Table 31-19, the minimum and maximum values for the temperature range of -40°C to +85°C are corrected to read as -30% for minimum and +30% for maximum.

4. Module: Electrical Characteristics

For Parameter DA01 (Positive Output Differential Voltage) in Table 31-48, the minimum value is corrected to read as 0.8V.

5. Module: Electrical Characteristics

Table 31-18: AC Characteristics: Internal RC Accuracy should be replaced with the following table.

TABLE 31-18: AC CHARACTERISTICS: INTERNAL RC ACCURACY

AC CHARACTERISTICS		Standard Operating Conditions: 3.0V to 3.6V (unless otherwise stated) Operating temperature -40°C ≤ TA ≤ +85°C for Industrial -40°C ≤ TA ≤ +125°C for Extended					
Param No.	Characteristic	Min	Typ	Max	Units	Conditions	
	Internal FRC Accuracy @ 7.3728 MHz ^(1,2)						
F20	FRC	-3	—	3	%	-40°C ≤ TA ≤ -10°C	VDD = 3.0-3.6V
	FRC	-2	—	2	%	-10°C ≤ TA ≤ +85°C	VDD = 3.0-3.6V
	FRC	-5	—	5	%	+85°C ≤ TA ≤ +125°C	VDD = 3.0-3.6V

Note 1: Frequency calibrated at +25°C and 3.3V. TUNx bits can be used to compensate for temperature drift.

2: Negative current is defined as current sourced by the pin.

6. Module: High-Temperature Electrical Characteristics

A new table, [Table 32-8](#): DC Characteristics: I/O Pin Input Specifications and Parameter HDI51f (Input Leakage Current, RB9-RB12), are added to this chapter under DC Characteristics. They are shown in [Table 32-8](#) below. The following tables in this chapter will be renumbered sequentially.

TABLE 32-8: DC CHARACTERISTICS: I/O PIN INPUT SPECIFICATIONS

DC CHARACTERISTICS			Standard Operating Conditions: 3.0V to 3.6V (unless otherwise stated) Operating temperature $-40^{\circ}\text{C} \leq T_A \leq +150^{\circ}\text{C}$ for Extended Temperature				
Param No.	Symbol	Characteristic	Min	Typ ⁽¹⁾	Max	Units	Conditions
HDI51f	IIL	Input Leakage Current, RB9 through RB12	—	—	±15	μA	$V_{SS} \leq V_{PIN} \leq V_{DD}$, pin at high-impedance, $-40^{\circ}\text{C} \leq T_A \leq +150^{\circ}\text{C}$

Note 1: Negative current is defined as current sourced by the pin.

7. Module: High-Temperature Electrical Characteristics

A new table, [Table 32-19](#): AC Characteristics: Internal FRC Accuracy, is added to this chapter under AC Characteristics. [Table 32-19](#) summarizes the internal oscillator tolerance over the entire temperature range.

TABLE 32-19: AC CHARACTERISTICS: INTERNAL FRC ACCURACY

AC CHARACTERISTICS		Standard Operating Conditions: 3.0V to 3.6V (unless otherwise stated) Operating temperature $-40^{\circ}\text{C} \leq T_A \leq +150^{\circ}\text{C}$ for High Temperature					
Param No.	Characteristic	Min	Typ	Max	Units	Conditions	
HF20	FRC ^(1,2)	-5	—	5	%	$-40^{\circ}\text{C} \leq T_A \leq +150^{\circ}\text{C}$	$V_{DD} = 3.0\text{-}3.6\text{V}$

Note 1: Negative current is defined as current sourced by the pin.

2: Frequency is calibrated at +25°C and 3.3V. The TUNx bits can be used to compensate for temperature drift.

APPENDIX A: REVISION HISTORY

Rev A Document (3/2009)

Initial release of this document; issued for revision A1, A2 and A3 silicon.

Includes silicon issues 1-2 ([UART](#)), 3-4 ([SPI](#)), 5-10 ([I²C](#)), 11-12 ([UART](#)), 13 ([Comparator](#)), 14 ([Internal Voltage Regulator](#)), 15 ([PSV Operations](#)), 16-17 ([ECAN™](#)), 18 ([CPU](#)), 19-20 ([PWM](#)) and 21 ([SPI](#)).

This document replaces the following errata document:

“dsPIC33FJ32MC302/304, dsPIC33FJ64MCX02/X04 and dsPIC33FJ128MCX02/X04 Rev. A1/A2/A3 Silicon Errata” (DS80372)

Rev B Document (4/2009)

Corrected part numbers.

Rev C Document (8/2009)

Added silicon issues 22 ([UART](#)) and 23-24 ([QE1](#)).

Rev D Document (1/2010)

Added Rev. A4 silicon information.

Added silicon issue 25 ([Audio DAC](#)).

Rev E Document (6/2010)

Updated silicon issue 18 ([CPU](#)).

Added silicon issues 26 ([ADC](#)), 27 ([JTAG](#)) and 28 ([RTCC](#)), and data sheet clarification 1 (DC Characteristics: I/O Pin Input Specifications).

Rev F Document (10/2010)

Updated the work around in silicon issue 26 ([ADC](#)).

Added silicon issue 29 ([All](#)).

Rev G Document (3/2011)

Removed data sheet clarification 1.

Updated the Affected Silicon Revisions for item 29 in [Table 2](#) and in silicon issue 29 ([All](#)).

Added silicon issue 30 ([I/O Port](#)).

Rev H Document (11/2011)

Updated the current Device Data Sheet revision to “F”.

Added Rev. A5 silicon information.

Added silicon issues 31 ([CPU](#)), 32 ([CPU](#)), 33 ([UART](#)), and 34 ([JTAG](#)).

Rev J Document (11/2013)

Updated the current Device Data Sheet revision to “G”.

Added data sheet clarifications 1 through 5 ([Electrical Characteristics](#)) and 6 through 7 ([High-Temperature Electrical Characteristics](#)).

Other minor typographic changes to improve table readability.

Rev K Document (11/2015)

Added silicon issue 35 ([I²C](#)).

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